

**Search Notes**

Application/Control No.

09/632,774

Examiner

Tri V. Nguyen

Applicant(s)/Patent under  
Reexamination

HAITSUKA ET AL.

Art Unit

1751

**SEARCHED**

Class	Subclass	Date	Examiner
705	14	5/5/2007	NVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see attached)	5/5/2007	NVT